

January 2008

74AC08, 74ACT08 **Quad 2-Input AND Gate**

Features

General Description

- I_{CC} reduced by 50% on 74AC only
- Outputs source/sink 24mA

The AC08/ACT08 contains four, 2-input AND gates.

Ordering Information

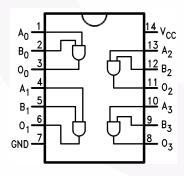
| Order Number | Package Number | Package Description |
|-----------------|-------------------|--|
| 74AC08SC | M14A | 14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow |
| 74AC08SJ | M14D | 14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide |
| 74AC08MTC | MTC14 | 14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide |
| 74AC08PC | N14A | 14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide |
| 74ACT08SC | M14A | 14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow |
| 74ACT08MTC | MTC14 | 14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide |
| 74ACT08PC | N14A | 14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide |

Device also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering number.

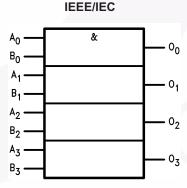


All packages are lead free per JEDEC: J-STD-020B standard.

Connection Diagram



Logic Symbol



Pin Description

| Pin Names | Description |
|---------------------------------|-------------|
| A _n , B _n | Inputs |
| O _n | Outputs |

Absolute Maximum Ratings

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.

| Symbol | Parameter | Rating |
|-------------------------------------|---|---------------------------------|
| V _{CC} | Supply Voltage | -0.5V to +7.0V |
| I _{IK} | DC Input Diode Current | |
| | $V_1 = -0.5V$ | –20mA |
| | $V_{I} = V_{CC} + 0.5$ | +20mA |
| VI | DC Input Voltage | -0.5V to V _{CC} + 0.5V |
| I _{OK} | DC Output Diode Current | |
| | $V_{O} = -0.5V$ | -20mA |
| | $V_{O} = V_{CC} + 0.5V$ | +20mA |
| Vo | DC Output Voltage | -0.5V to V _{CC} + 0.5V |
| Io | DC Output Source or Sink Current | ±50mA |
| I _{CC} or I _{GND} | DC V _{CC} or Ground Current per Output Pin | ±50mA |
| T _{STG} | Storage Temperature | -65°C to +150°C |
| TJ | Junction Temperature | 140°C |

Recommended Operating Conditions

The Recommended Operating Conditions table defines the conditions for actual device operation. Recommended operating conditions are specified to ensure optimal performance to the datasheet specifications. Fairchild does not recommend exceeding them or designing to absolute maximum ratings.

| Symbol | Parameter | Rating | | | |
|-----------------|--|--------------|--|--|--|
| V _{CC} | Supply Voltage | | | | |
| | AC | 2.0V to 6.0V | | | |
| | ACT | 4.5V to 5.5V | | | |
| VI | Input Voltage 0V to | | | | |
| V _O | Output Voltage 0V to | | | | |
| T _A | Operating Temperature -40°C to +85° | | | | |
| ΔV / Δt | Minimum Input Edge Rate, AC Devices: 125mV/n | | | | |
| | $V_{\rm IN}$ from 30% to 70% of $V_{\rm CC}$, $V_{\rm CC}$ @ 3.3V, 4.5V, 5.5V | | | | |
| ΔV / Δt | Minimum Input Edge Rate, ACT Devices: 125mV/n | | | | |
| | V _{IN} from 0.8V to 2.0V, V _{CC} @ 4.5V, 5.5V | | | | |

DC Electrical Characteristics for AC

| | V_{CC} $T_A = +$ | | +25°C | T _A = -40°C to +85°C | | | |
|--------------------------------|-------------------------------------|-----|---|---------------------------------|------|------------------|-------|
| Symbol | Parameter | (V) | Conditions | Тур. | G | uaranteed Limits | Units |
| V _{IH} | Minimum HIGH Level | 3.0 | $V_{OUT} = 0.1V$ or | 1.5 | 2.1 | 2.1 | V |
| | Input Voltage | 4.5 | V _{CC} – 0.1V | 2.25 | 3.15 | 3.15 | |
| | | 5.5 | | 2.75 | 3.85 | 3.85 | |
| V _{IL} | Maximum LOW Level | 3.0 | $V_{OUT} = 0.1V$ or | 1.5 | 0.9 | 0.9 | V |
| | Input Voltage | 4.5 | V _{CC} – 0.1V | 2.25 | 1.35 | 1.35 | |
| | | 5.5 | | 2.75 | 1.65 | 1.65 | |
| V _{OH} | Minimum HIGH Level | 3.0 | $I_{OUT} = -50\mu A$ | 2.99 | 2.9 | 2.9 | V |
| | Output Voltage | 4.5 | | 4.49 | 4.4 | 4.4 | |
| | | 5.5 | | 5.49 | 5.4 | 5.4 | |
| | | 3.0 | $V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OH} = -12\text{mA}$ | | 2.56 | 2.46 | |
| | | 4.5 | $V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OH} = -24\text{mA}$ | | 3.86 | 3.76 | |
| | | 5.5 | $V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OH} = -24\text{mA}^{(1)}$ | | 4.86 | 4.76 | |
| V _{OL} | Maximum LOW Level | 3.0 | $I_{OUT} = 50\mu A$ | 0.002 | 0.1 | 0.1 | V |
| | Output Voltage | 4.5 | | 0.001 | 0.1 | 0.1 | |
| | | 5.5 | | 0.001 | 0.1 | 0.1 | |
| | | 3.0 | $V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OL} = 12\text{mA}$ | | 0.36 | 0.44 | |
| | | 4.5 | $V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OL} = 24\text{mA}$ | | 0.36 | 0.44 | |
| | | 5.5 | $V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OL} = 24\text{mA}^{(1)}$ | | 0.36 | 0.44 | |
| I _{IN} ⁽³⁾ | Maximum Input Leakage Current | 5.5 | $V_I = V_{CC}$, GND | | ±0.1 | ±1.0 | μA |
| I _{OLD} | Minimum Dynamic | 5.5 | V _{OLD} = 1.65V Max. | | | 75 | mA |
| I _{OHD} | Output Current ⁽²⁾ | 5.5 | V _{OHD} = 3.85V Min. | | | – 75 | mA |
| I _{CC} ⁽³⁾ | Maximum Quiescent Supply Current | 5.5 | $V_{IN} = V_{CC}$ or GND | | 2.0 | 20.0 | μA |

Notes:

- 1. All outputs loaded; thresholds on input associated with output under test.
- 2. Maximum test duration 2.0ms, one output loaded at a time.
- 3. $I_{\mbox{\footnotesize{IN}}}$ and $I_{\mbox{\footnotesize{CC}}}$ @ 3.0V are guaranteed to be less than or equal to the respective limit @ 5.5V $V_{\mbox{\footnotesize{CC}}}.$

DC Electrical Characteristics for ACT

| | | V _{CC} | | T _A = + | +25°C | T _A = -40°C to +85°C | |
|------------------|-------------------------------------|-----------------|--|--------------------|-------|---------------------------------|-------|
| Symbol | Parameter | (V) | Conditions | Тур. | G | Buaranteed Limits | Units |
| V _{IH} | Minimum HIGH Level | 4.5 | $V_{OUT} = 0.1V$ or | 1.5 | 2.0 | 2.0 | V |
| | Input Voltage | 5.5 | V _{CC} – 0.1V | 1.5 | 2.0 | 2.0 | |
| V _{IL} | Maximum LOW Level | 4.5 | $V_{OUT} = 0.1V$ or | 1.5 | 0.8 | 0.8 | V |
| | Input Voltage | 5.5 | V _{CC} – 0.1V | 1.5 | 0.8 | 0.8 |] |
| V _{OH} | Minimum HIGH Level | 4.5 | $I_{OUT} = -50\mu A$ | 4.49 | 4.4 | 4.4 | V |
| | Output Voltage | 5.5 | | 5.49 | 5.4 | 5.4 |] |
| | | 4.5 | $V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OH} = -24\text{mA}$ | | 3.86 | 3.76 | |
| | | 5.5 | $V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OH} = -24\text{mA}^{(4)}$ | | 4.86 | 4.76 | |
| V _{OL} | Maximum LOW Level | 4.5 | I _{OUT} = 50μA | 0.001 | 0.1 | 0.1 | V |
| | Output Voltage | 5.5 | | 0.001 | 0.1 | 0.1 | |
| | | 4.5 | $V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OL} = 24\text{mA}$ | | 0.36 | 0.44 | |
| | | 5.5 | $V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OL} = 24\text{mA}^{(4)}$ | | 0.36 | 0.44 | |
| I _{IN} | Maximum Input Leakage Current | 5.5 | $V_I = V_{CC}$, GND | | ±0.1 | ±1.0 | μA |
| I _{CCT} | Maximum I _{CC} /Input | 5.5 | $V_I = V_{CC} - 2.1V$ | 0.6 | | 1.5 | mA |
| I _{OLD} | Minimum Dynamic | 5.5 | $V_{OLD} = 1.65V Max.$ | | | 75 | mA |
| I _{OHD} | Output Current ⁽⁵⁾ | 5.5 | V _{OHD} = 3.85V Min. | | | - 75 | mA |
| I _{CC} | Maximum Quiescent Supply Current | 5.5 | $V_{IN} = V_{CC}$ or GND | | 4.0 | 40.0 | μA |

Notes:

- 4. All outputs loaded; thresholds on input associated with output under test.
- 5. Maximum test duration 2.0ms, one output loaded at a time.

AC Electrical Characteristics for AC

| | | | T _A = +25°C, C _L = 50pF | | $T_A = -40$ °C to +85°C, $C_L = 50$ pF | | | |
|------------------|-------------------|------------------------------------|--|------|---|------|------|-------|
| Symbol | Parameter | V _{CC} (V) ⁽⁶⁾ | Min. | Тур. | Max. | Min. | Max. | Units |
| t _{PLH} | Propagation Delay | 3.3 | 1.5 | 7.5 | 9.5 | 1.0 | 10.0 | ns |
| | | 5.0 | 1.5 | 5.5 | 7.5 | 1.0 | 8.5 | |
| t _{PHL} | Propagation Delay | 3.3 | 1.5 | 7.0 | 8.5 | 1.0 | 9.0 | ns |
| | | 5.0 | 1.5 | 5.5 | 7.0 | 1.0 | 7.5 | |

Note:

6. Voltage range 3.3 is $3.3V \pm 0.3V$. Voltage range 5.0 is $5.0V \pm 0.5V$.

AC Electrical Characteristics for ACT

| | | | | \ = +25° L = 50p | | T _A = -40°C C _L = | to +85°C, 50pF | |
|------------------|-------------------|-------------------|------|---------------------|------|--|-------------------|-------|
| Symbol | Parameter | $V_{CC}(V)^{(7)}$ | Min. | Тур. | Max. | Min. | Max. | Units |
| t _{PLH} | Propagation Delay | 5.0 | 1.0 | 6.5 | 9.0 | 1.0 | 10.0 | ns |
| t _{PHL} | Propagation Delay | 5.0 | 1.0 | 6.5 | 9.0 | 1.0 | 10.0 | ns |

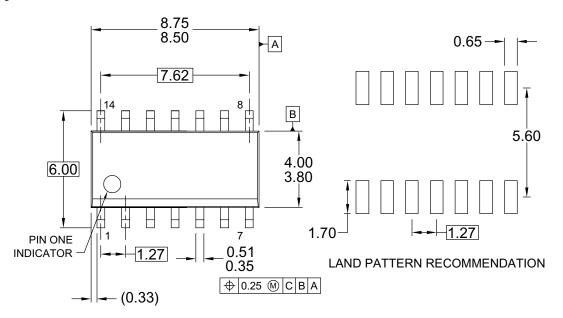
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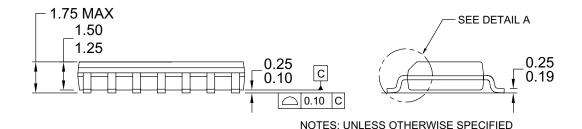
7. Voltage range 5.0 is $5.0V \pm 0.5V$.

Capacitance

| Symbol | Parameter | Conditions | Тур. | Units |
|-----------------|-------------------------------|------------------------|------|-------|
| C _{IN} | Input Capacitance | V _{CC} = OPEN | 4.5 | pF |
| C _{PD} | Power Dissipation Capacitance | $V_{CC} = 5.0V$ | 20.0 | pF |

Physical Dimensions





R0.10

R0.10

R0.10

R0.10

Seating Plane

O.50

- A) THIS PACKAGE CONFORMS TO JEDEC MS-012, VARIATION AB, ISSUE C,
- B) ALL DIMENSIONS ARE IN MILLIMETERS.
- C) DIMENSIONS DO NOT INCLUDE MOLD FLASH OR BURRS.
- D) LANDPATTERN STANDARD: SOIC127P600X145-14M
- E) DRAWING CONFORMS TO ASME Y14.5M-1994
- F) DRAWING FILE NAME: M14AREV13

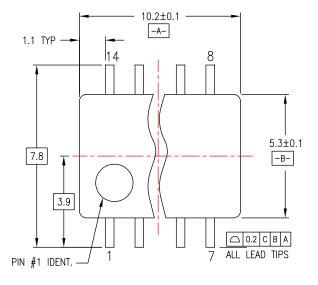
Figure 1. 14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow

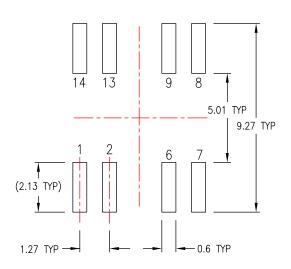
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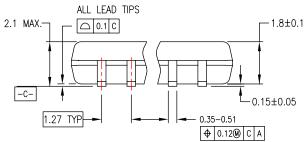
http://www.fairchildsemi.com/packaging/

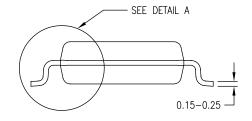
Physical Dimensions (Continued)





LAND PATTERN RECOMMENDATION



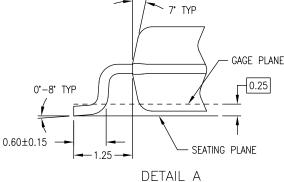


DIMENSIONS ARE IN MILLIMETERS

NOTES:

- A. CONFORMS TO EIAJ EDR-7320 REGISTRATION, ESTABLISHED IN DECEMBER, 1998.
 B. DIMENSIONS ARE IN MILLIMETERS.
 C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD

FLASH, AND TIE BAR EXTRUSIONS.



M14DREVC

Figure 2. 14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide

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Physical Dimensions (Continued) 5.0±0.1 -A-0.65 0.43 TYP 6.4 4.4±0.1 -B-1.65 3.2 □ 0.2 C B A PIN #1 IDENT. 6.10 0.45 -LAND PATTERN RECOMMENDATION SEE DETAIL A ALL LEAD TIPS 0.90+0.15 1.2 MAX □ 0.1 C 0.09-0.20 -C-0.10±0.05 0.65 0.19 - 0.30⊕ |0.13\\(\) |A |B\(\) |C\(\) 12.00°TOP & BOTTOM R0.09 min GAGE PLANE 0.25 0°-8° NOTES: 0.6±0.1 A. CONFORMS TO JEDEC REGISTRATION MO-153, SEATING PLANE R0.09min VARIATION AB, REF NOTE 6 -1 00 **B. DIMENSIONS ARE IN MILLIMETERS DETAIL A**

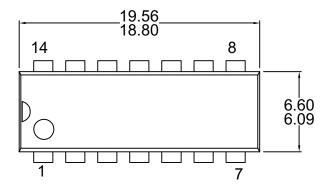
- C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS
- D. DIMENSIONING AND TOLERANCES PER ANSI Y14.5M, 1982
- E. LANDPATTERN STANDARD: SOP65P640X110-14M
- F. DRAWING FILE NAME: MTC14REV6

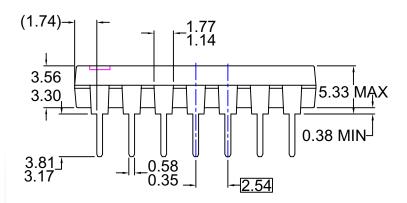
Figure 3. 14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide

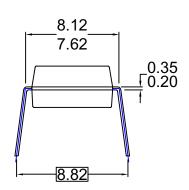
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Physical Dimensions (Continued)







NOTES: UNLESS OTHERWISE SPECIFIED THIS PACKAGE CONFORMS TO

- A) JEDEC MS-001 VARIATION BA
- B) ALL DIMENSIONS ARE IN MILLIMETERS.
 DIMENSIONS ARE EXCLUSIVE OF BURRS.
- C) MOLD FLASH, AND TIE BAR EXTRUSIONS.
- D) DIMENSIONS AND TOLERANCES PER ASME Y14.5-1994
- E) DRAWING FILE NAME: MKT-N14AREV7

Figure 4. 14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide

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